INTERNATIONAL STANDARD

ISO/IEC 15457-3

First edition 2002-06-01

Identification cards — Thin flexible cards —

Part 3: **Test methods**

Cartes d'identification — Cartes flexibles fines —

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ISO/IEC 15457-3:2002 https://standards.iteh.ai/catalog/standards/sist/f51e6350-d515-4e52-8fab-f6872320f4f2/iso-iec-15457-3-2002



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Contents

Page

Forewo	ord	νi
1	Scope	. 1
2	Normative references	. 1
3	Terms and definitions	. 3
4	Test methods for physical characteristics	
4.1	General	. 4
4.1.1	Reference	. 4
4.1.2	Apparatus	. 4
4.1.3	Sampling, preparation and storage of samples	. 4
4.1.4	Conditioning and testing environment	
4.1.5	Test report	
4.2	Dimensions (except thickness)	. 5
4.2.1	Reference	
4.2.2	Principle	
4.2.3	Procedure	
4.3		
4.3.1	Thickness Reference ITeh STANDARD PREVIEW	5
4.3.2	Annaratus	. 5 5
4.3.3	Apparatus (Standards.iteh.ai)	. J
4.4	Separation force	
4.4.1	Reference Programme 1990 Reference Programme 1	
4.4.2		
4.4.3	Principle imps://standards.iteh.ai/catalog/standards/sist/i51e6350-d515-4e32-8fab-	٥.
4.4.3 4.4.4	Apparatus 108723201412780-iec-15437-3-2002 Procedure	o . ء
4.4.5	Expression of result	. O
4.4.5 4.5		
4.5 4.5.1	Reel winding	
	Reference	
4.5.2	Apparatus	
4.5.3	Procedure	
4.6	Bursting strength	
4.6.1	Reference	
4.6.2	Procedure	
4.7	Stiffness	
4.7.1	Reference	
4.7.2	Procedure	
4.8	Folding endurance	
4.8.1	Reference	
4.8.2	Apparatus	
4.8.3	Procedure	
4.9	Ash content	
4.9.1	Reference	
4.9.2	Procedure	
4.10	Smoothness	
4.10.1	Reference	
4.10.2	Procedure	
4.11	Opacity (paper backing) and opacity (700-1 000 nm)	
4.11.1		
4.11.2	Procedure	
4.12	Coefficient of friction and destacking force	
4.12.1	Reference	. 9

ISO/IEC 15457-3:2002(E)

4.12.2	Procedure	
4.13	Reflectance factor	10
4.13.1	Reference	10
4.13.2	Procedure	10
4.14	Air permeance	
4.14.1	Reference	
4.14.2	Procedure	
4.15	Sizing and pen-writing factor	
4.15 4.15.1	Reference	
_		
4.15.2	Principle	
4.15.3	Apparatus and reagents	
4.15.4	Preparation of test pieces	
4.15.5	Procedure	
4.15.6	Expression of results	
4.16	Tear resistance	
4.16.1	Reference	
4.16.2	Procedure	
4.17	Delamination resistance	
4.17.1	Reference	
4.17.2	Principle	
4.17.3	Apparatus	
4.17.4	Preparation for test	
4.17.5	Procedure	15
4.17.6	Expression of results	16
4.17.7	Test report	16
4.18	Cold-crack temperature (brittleness) A. N.D. A. D.D. D.D. E.X./I.E.XX/	18
4.18.1	Cold-crack temperature (brittleness)	18
4.18.2	Procedure (ctoredonds itals ai)	18
4.18.3	Procedure (standards.iteh.ai) Expression of results	18
5	Test methods for magnetic stripe physical characteristics	
5.1	Preparation and storage of samples was a storage of samples with the samples was a storage of sa	19
5.1 5.2	Preparation and storage of samples i/catalog/standards/sist/f51e6950-d515-4e52-8fab	19 19
5.1 5.2 5.3	Preparation and storage of samples i/catalog/standards/sist/t5/te6950-d5/15-4e52-8fab- Conditioning and test environments/2320/4/2/su-jec-15457-3-2002 Protrusion	19 19 19
5.1 5.2 5.3 5.3.1	Preparation and storage of samples of cutalog sundards/sist/51e6350-d515-4e52-8fab- Conditioning and test environments/2320/4/2/su-iec-15457-3-2002 Protrusion Reference	19 19 19
5.1 5.2 5.3 5.3.1 5.3.2	Preparation and storage of samples average standards/sist/57e6350-d575-4e52-8fab- Conditioning and test environments/2320f4f2/isu-jec-15457-3-2002 Protrusion Reference Principle	19 19 19 19
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3	Preparation and storage of samples in catalog standards/sist/f31e6350-d315-4e52-8fab- Conditioning and test environments/2320f4f2/isu-ieu-15457-3-2002 Protrusion Reference Principle Apparatus	19 19 19 19
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4	Preparation and storage of samples average standards/sist/f51e6350-d515-4e52-8fab- Conditioning and test environments/232004f2/isu-ieu-15457-3-2002 Protrusion Reference Principle Apparatus Procedure	19 19 19 19 19
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4	Preparation and storage of samples available standards/sist/f31e0350-d315-4e52-8fab- Conditioning and test environments/232004f2/su-jec-13437-3-2002 Protrusion Reference Principle Apparatus Procedure Profile deviation	19 19 19 19 19 20
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4 5.4.1	Preparation and storage of samples available standards/sist/f51e0350-d515-4e52-8fab- Conditioning and test environments/232004f2/su-jec-15437-3-2002 Protrusion Reference Principle Apparatus Procedure Profile deviation Reference	19 19 19 19 19 20 20
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4 5.4.1	Preparation and storage of samples available standards/sist/f31e0350-d315-4e52-8fab- Conditioning and test environments/232004f2/su-jec-13437-3-2002 Protrusion Reference Principle Apparatus Procedure Profile deviation	19 19 19 19 19 20 20
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4 5.4.1	Preparation and storage of samples available standards/sist/57e6350-d575-4e52-8fab- Conditioning and test environments/232004f2/su-iec-15457-3-2002 Protrusion Reference Principle Apparatus Procedure Profile deviation Reference Principle Procedure Procedure	19 19 19 19 20 20 20
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4 5.4.1	Preparation and storage of samples available standards/sist/57e6350-d575-4e52-8fab- Conditioning and test environments/2320f4f2/isu-iec-15457-3-2002 Protrusion Reference Principle Apparatus Procedure Profile deviation Reference Principle	19 19 19 19 20 20 20
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4 5.4.1 5.4.2 5.4.3	Preparation and storage of samples available standards/sist/57e6350-d575-4e52-8fab- Conditioning and test environments/232004f2/su-iec-15457-3-2002 Protrusion Reference Principle Apparatus Procedure Profile deviation Reference Principle Procedure Procedure	19 19 19 19 20 20 20 21
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.4.3 5.5.5	Preparation and storage of samples incatalog standards/sist/15 1e03 50 -d3 15 - 4e52 - 8 fab- Conditioning and test environments / 23 20 14 12 / 150 - iec - 15 45 7 - 3 - 200 2 Protrusion Reference Principle Apparatus Procedure Profile deviation Reference Principle Procedure Procedure Roughness Ra and Rz	19 19 19 19 20 20 20 21
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.4.3 5.5.5	Preparation and storage of samples available standards six of 5 to 350 to 3515 to 35	19 19 19 19 20 20 20 21 21
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.4.3 5.5.1 5.5.1	Preparation and storage of samples availables available	19 19 19 19 20 20 20 21 21 21
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.4.3 5.5.1 5.5.1 5.5.2 5.5.3 5.6	Preparation and storage of samples available size and size $1.000000000000000000000000000000000000$	19 19 19 19 20 20 20 21 21 21 21
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.4.3 5.5.1 5.5.5.1 5.5.2 5.5.3 5.6	Preparation and storage of samples weutalogstant and visit 15 to 45 to 4	19 19 19 19 20 20 20 21 21 21 21
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.5.1 5.5.5.1 5.5.2 5.5.3 5.6.1 5.6.2	Preparation and storage of samples weatalog stantands/sis/15/e6959-d515-de52-86b- Conditioning and test environments/2320/P12/su-ice-15457-3-2002 Protrusion Reference Principle Apparatus Procedure Profile deviation Reference Principle Procedure Roughness Ra and Rz Reference Principle Procedure Roughness Ra and Rz Reference Principle Procedure Roughnese Ra and Rz Reference Principle Procedure Roughnese Ra and Rz	19 19 19 19 20 20 20 21 21 21 21 21 21
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.5.5 5.5.5.2 5.5.3 5.6.1 5.6.2 5.7	Preparation and storage of samples conditioning and test environments 2320412 so-test 13457-3-2002 Protrusion Reference Principle Apparatus Procedure Profile deviation Reference Principle Roughness Ra and Rz Reference Principle Roughness Ra and Rz Reference Roughness Ra and Rz Reference Principle Procedure Roughness Ra and Rz Reference Principle Procedure Roughness Ra and Rz Reference Principle Procedure Roughness Ra Reference Principle Procedure Roughness Ra Reference Procedure Reference R	19 19 19 19 20 20 21 21 21 21 21 22 22 22
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.4.3 5.5.1 5.5.5 5.5.1 5.5.2 5.6.1 5.6.2 5.7	Preparation and storage of samples variables v	19 19 19 19 20 20 20 21 21 21 21 22 22 22
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.4.3 5.5.5 5.5.1 5.5.5.2 5.6.1 5.6.2 5.7.1 5.7.1	Preparation and storage of samples reunalog suntinds/sist/01e0350-d515-de32-8hb- Conditioning and test environments/2320/412/80-100-13457-3-2002 Protrusion Reference Principle Apparatus Procedure Profile deviation Reference Principle Procedure Roughness Ra and Rz Reference Principle Procedure Roughness Ra end Rz Reference Principle Procedure Roughnese Ra end Rz Reference Principle Procedure Reference Principle Reference Principle Reference	19 19 19 19 20 20 20 21 21 21 21 22 22 22 22
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.4.3 5.5.1 5.5.5 5.5.3 5.6.1 5.6.2 5.7.1 5.7.2 5.7.3	Preparation and storage of samples was allowed by the storage of storage of samples was allowed by the storage of samples was allowed by the storage of samples of samp	19 19 19 19 20 20 20 21 21 21 21 22 22 22 22 22
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.4.3 5.5.1 5.5.5 5.5.3 5.6.1 5.6.2 5.7.1 5.7.2 5.7.3 5.7.3	Preparation and storage of samples conditioning and test environments 232004 2550-2650-2650-2650-2650-2650-2650-2650-	19 19 19 19 20 20 20 21 21 21 21 22 22 22 22 22 22
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.5.5 5.5.5 5.5.5 5.6.1 5.7.1 5.7.2 5.7.3 5.8.1	Preparation and storage of samples catalog surting systems and a storage of samples catalog systems and a storage of samples	19 19 19 19 20 20 20 21 21 21 21 22 22 22 22 22 22 22 22
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.5.5 5.5.5 5.5.5 5.6.1 5.7.1 5.7.2 5.7.3 5.8.1 5.8.2	Preparation and storage of samples and accomposition and storage and accomposition accomposition accomposition and accomposition accomposition and accomposition acco	19 19 19 19 20 20 20 21 21 21 21 22 22 22 22 22 22 22 22
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.4.1 5.4.2 5.5.5 5.5.5 5.5.5 5.6.1 5.7.2 5.7.3 5.8.1 5.8.2 5.8.3	Preparation and storage of samples conting surface 200 (200 (200 (200 (200 (200 (200 (200	19 19 19 19 20 20 20 21 21 21 21 22 22 22 22 22 22 22 22 22
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.4.1 5.4.2 5.5.1 5.5.5.5 5.5.5.3 5.6.1 5.6.2 5.7.1 5.7.2 5.7.3 5.8.1 5.8.2 5.8.3 5.8.3	Preparation and storage of samples Conditioning and test environments Protrusion Reference Principle Apparatus Procedure Profile deviation Reference Principle Procedure Roughness Ra and Rz Reference Principle Procedure Warpage Reference Procedure Adherence Reference Apparatus Procedure Wear test Reference Principle Procedure Dimensional measurement of the magnetic stripe	19 19 19 19 20 20 20 21 21 21 21 21 22 22 22 22 22 22 22 22
5.1 5.2 5.3 5.3.1 5.3.2 5.3.3 5.3.4 5.4.1 5.4.2 5.5.5 5.5.5 5.5.5.2 5.5.5.3 5.6.1 5.7.2 5.7.3 5.8.1 5.8.2 5.8.3	Preparation and storage of samples conting surface 200 (200 (200 (200 (200 (200 (200 (200	19 19 19 19 20 20 21 21 21 21 22 22 22 22 22 22 23 23

6	Test methods for static magnetic characteristics	23
6.1	Principle	23
6.2	Apparatus	23
6.3	Preparation and storage of sample	24
6.3.1	Preparation	24
6.3.2	Storage	24
6.3.3	Conditioning and testing environment	24
6.4	Procedure	24
6.4.1	VSM	24
6.4.2	НМ	25
6.5	Expression of results	25
6.6	Coercivity, H_{cM}	26
6.6.1	Reference	
6.6.2	Procedure	26
6.7	Squareness, SQ	27
6.7.1	Reference	27
6.7.2	Procedure	
6.8	Switching field distribution, (SF _D)	27
6.8.1	Reference	27
6.8.2	Procedure	
6.9	Test report	27
7	Test method for dynamic magnetic characteristics	28
, 7.1	Principle	
7.1 7.2	Reference cards	
7.2 7.3		
7.3.1	Apparatus	20 20
7.3.1 7.3.2	Measuring instrument for class H	20 28
7.3. <u>2</u> 7.4	Measuring instrument for class HPreparation and preservation of test samples Saltehaal.	20
7. 4 .1	Preparation	20
7. 4 .1 7.4.2	Preservation FOOTEC 15457-2-2002	
7.4.2 7.4.3	Conditioning and testing environment conditioning e	
7. 4 .5 7.5	Test procedure	29
7.5.1	Test procedure $\frac{1687232201412/is0-ieu-15437-3-2002}{1687232201412/is0-ieu-15437-3-2002}$	29
7.5.1 7.6	Expression of results	23 20
7.6.1	Resolution	
7.6.1 7.6.2	Modulation	
7.0.2 7.7	Test report	
	·	
Biblio	graphygraphy	31

Foreword

ISO (the International Organization for Standardization) and IEC (the International Electrotechnical Commission) form the specialized system for worldwide standardization. National bodies that are members of ISO or IEC participate in the development of International Standards through technical committees established by the respective organization to deal with particular fields of technical activity. ISO and IEC technical committees collaborate in fields of mutual interest. Other international organizations, governmental and non-governmental, in liaison with ISO and IEC, also take part in the work. In the field of information technology, ISO and IEC have established a joint technical committee, ISO/IEC JTC 1.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 3.

The main task of the joint technical committee is to prepare International Standards. Draft International Standards adopted by the joint technical committee are circulated to national bodies for voting. Publication as an International Standard requires approval by at least 75 % of the national bodies casting a vote.

Attention is drawn to the possibility that some of the elements of this part of ISO/IEC 15457 may be the subject of patent rights. ISO and IEC shall not be held responsible for identifying any or all such patent rights.

ISO/IEC 15457-3 was prepared by Joint Technical Committee ISO/IEC JTC 1, Information technology, Subcommittee SC 17, Identification cards and related devices.

ISO/IEC 15457 consists of the following parts, under the general title Identification cards — Thin flexible cards:

Part 1: Physical characteristics

ISO/IEC 15457-3:2002

Part 2: Magnetic recording techniques steh ai/catalog/standards/sist/f51e6350-d515-4e52-8fab-

f6872320f4f2/iso-iec-15457-3-2002

Part 3: Test methods

Identification cards — Thin flexible cards —

Part 3:

Test methods

1 Scope

Thin flexible cards, the subject of this International Standard, are used to automate the controls for access to goods or services such as mass transit, highway toll systems, car parks, vouchers, stored value, etc.

For these applications, data can be written and/or read by machines using various recording techniques such as magnetic stripe, optical character recognition (OCR), bar code, etc.

This part of ISO/IEC 15457 specifies the test methods and procedures required to carry out measurements of the magnetic stripe and encoding characteristics of thin flexible cards.

Many of the standard methods available for checking physical properties of base materials are intended to be applied to samples cut from continuous material or large sheets. However, all test methods given herein, unless explicitly stated otherwise, apply to finished cards.

The test methods described are to be performed on separate samples. It is not intended that any individual card should pass through more than one test procedure, unless explicitly stated 5-4e52-8fab-

f6872320f4f2/iso-iec-15457-3-2002

Acceptance criteria do not form part of this standard.

2 Normative references

The following normative documents contain provisions which, through reference in this text, constitute provisions of this part of ISO/IEC 15457. For dated references, subsequent amendments to, or revisions of, any of these publications do not apply. However, parties to agreements based on this part of ISO/IEC 15457 are encouraged to investigate the possibility of applying the most recent editions of the normative documents indicated below. For undated references, the latest edition of the normative document referred to applies. Members of ISO and IEC maintain registers of currently valid International Standards.

ISO 186, Paper and board — Sampling to determine average quality

ISO 187, Paper, board and pulps — Standard atmosphere for conditioning and testing and procedure for monitoring the atmosphere and conditioning of samples

ISO 284, Conveyor belts — Electrical conductivity — Specification and method of test

ISO 291, Plastics — Standard atmospheres for conditioning and testing

ISO 527-3, Plastics — Determination of tensile properties — Part 3: Test conditions for films and sheets

ISO 534, Paper and board — Determination of thickness and apparent bulk density or apparent sheet density

ISO 1831, Printing specifications for optical character recognition

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ISO 1924-2, Paper and board — Determination of tensile properties — Part 2: Constant rate of elongation method
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ISO 2144, Paper, board and pulps — Determination of residue (ash) on ignition at 900 °C

ISO 2409, Paints and varnishes — Cross-cut test

ISO 2471, Paper and board — Determination of opacity (paper backing) — Diffuse reflectance method

ISO 2758, Paper — Determination of bursting strength

ISO 3274, Geometrical Product Specifications (GPS) — Surface texture: Profile method — Nominal characteristics of contact (stylus) instruments

ISO 4094, Paper, board and pulps — International calibration of testing apparatus — Nomination and acceptance of standardizing and authorized laboratories

ISO 4287-1, Surface roughness — Terminology — Part 1: Surface and its parameters

ISO 4593, Plastics — Film and sheeting — Determination of thickness by mechanical scanning

ISO 5626, Paper — Determination of folding endurance

ISO 5627, Paper and board — Determination of smoothness (Bekk method)

ISO 5629, Paper and board — Determination of bending stiffness — Resonance method

ISO 5636-3, Paper and board — Determination of air permeance (medium range) — Part 3: Bendtsen method ISO/IEC 15457-3:2002

ISO 6383-2, Plastics — Filmland/sheeting.itch Determination of tears resistance 5-4 Bart 2b Elmendorf method f6872320f4f2/iso-iec-15457-3-2002

ISO 8226-2, Paper and board — Measurement of hygroexpansivity — Part 2: Hygroexpansivity up to a maximum relative humidity of 86 %

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ISO 8295, Plastics — Film and sheeting — Determination of coefficients of friction

ISO 8570, Plastics — Film and sheeting — Determination of cold-crack temperature

ISO/IEC 7811-2, Identification cards — Recording technique — Part 2: Magnetic stripe — Low coercivity

ISO/IEC 7811-6, Identification cards — Recording technique — Part 6: Magnetic stripe — High coercivity

ISO/IEC 10373-1, Identification cards — Test methods — Part 1: General characteristics tests

ISO/IEC 10373-2, Identification cards — Test methods — Part 2: Cards with magnetic stripes

ISO/IEC 15457-1, Identification cards — Thin flexible cards — Part 1: Physical characteristics

ISO/IEC 15457-2, Identification cards — Thin flexible cards — Part 2: Magnetic recording technique

IEC 60050-221, International Electrotechnical Vocabulary — Chapter 221: Magnetic materials and components

IEC 60454-2, Specifications for pressure-sensitive adhesive tapes for electrical purposes — Part 2: Methods of test

Terms and definitions

For the purposes of this part of ISO/IEC 15457, the terms and definitions given in ISO/IEC 15457-1, ISO/IEC 15457-2 and the following apply.

3.1

substrate

material of which the TFC is made without any recording media

3.2

composite

material made from at least two layers of different material, one of which is paper

3.3

reference signal amplitude

 U_{R}

primary standard read back signal amplitude; the maximum value of the average signal amplitude of the reference card, corrected to the primary standard

reference write current

primary standard write current, obtained from the secondary reference card by measurement

3.5 reference flux

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flux in the test write head when the write current is a rds.iteh.ai)

3.6

ISO/IEC 15457-3:2002

test piece standards/sist/f51e6350-d515-4e52-8fab-

part of the sample or test sample on which the test is conducted -3-2002

3.7

uncertainty of measurement

an estimate characterising the range of values within which the true value of a measurand lies

[International vocabulary of basic and general terms in metrology]

3.8

(optical) transmittance factor

ratio of the measured (optical) flux transmitted by a specimen to the measured flux when the specimen is removed from the sampling aperture of the measuring device:

$$T = \Phi_{\tau}/\Phi_{i}$$

where

Tis the transmittance factor;

 Φ_{τ} is the transmitted (optical) flux;

 Φ_i is the aperture flux.

[ISO 5-2:1991]

ISO/IEC 15457-3:2002(E)

3.9

opacity

(optical) transmission density

 D_{τ}

logarithm to the base 10 of the reciprocal of the transmittance factor:

$$D_T = \log_{10} 1/T = \log_{10} \Phi_i/\Phi_\tau$$

[ISO 5-2:1991]

4 Test methods for physical characteristics

4.1 General

4.1.1 Reference

ISO/IEC 15457-1, Physical characteristics.

4.1.2 Apparatus

In order to obtain consistent and reproducible results, the apparatus and test devices used to carry out the tests shall comply with ISO 4094, wherever applicable.

4.1.3 Sampling, preparation and storage of samples RD PREVIEW

4.1.3.1 **Sampling**

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The sampling shall be in accordance with Table 1. SO/IEC 15457-3:2002 https://standards.iteh.ai/catalog/standards/sist/f51e6350-d515-4e52-8fab-

In certain cases samples may be taken from the base material before card manufacture if it can be demonstrated that no significant change in the property to be tested can arise during subsequent processing.

The samples used to prepare a set of test pieces shall be taken from the same batch of TFC base material.

4.1.3.2 Preparation

Test samples shall wherever possible be either finished cards or prepared from finished cards. They shall be conditioned in accordance with 4.1.4.

Test pieces shall, as necessary, be prepared from the test samples in the particular form required by the test apparatus used.

4.1.3.3 Storage

Any test samples or test pieces retained for reference shall be stored under the environmental conditions specified in 5.3.2 of ISO/IEC 15457-1 in such a manner that degradation due to moisture, light, physical distortion, plasticisers and other contamination shall not occur.

All such samples shall be clearly cross-referenced to the test report and any relevant supplementary documentation.

4.1.4 Conditioning and testing environment

Unless otherwise specified, the conditioning of test samples, and environment for the tests specified in this standard shall be in accordance with Table 1.

Table 1 — Sampling, conditioning and test environment parameters

Card material	Sampling	Conditioning and testing environment standard	Conditioning and testing environment atmosphere ^a	
Paper	ISO 186	ISO 187	23 °C/50 °C ordinary tolerances	
Composite	ISO 186	ISO 187	23 °C/50 °C ordinary tolerances	
Plastic	ISO 186	ISO 291	normal atmosphere 23 °C/50 °C	
^a "Ordinary tolerances" and "normal atmosphere" are explicit terms taken from the referenced standards.				

4.1.5 Test report

The test report shall be accurate, clear and ensure full traceability.

4.2 Dimensions (except thickness)

4.2.1 Reference

ISO/IEC 15457-1, Geometry.

ISO/IEC 15457-1, Positioning features.

4.2.2 Principle iTeh STANDARD PREVIEW

The principle is direct linear measurement. The dimensions shall be measured with an accuracy appropriate to the tolerance of the prescribed value of the characteristics of ISO/IEC 15457-1.

4.2.3 Procedure

ISO/IEC 15457-3:2002

https://standards.iteh.ai/catalog/standards/sist/f51e6350-d515-4e52-8fab-

Measure TFC dimensions using a method and apparatus that ensures a total measurement uncertainty equal to or less than 25 % of the absolute value of the tolerance of the dimension to be checked.

EXAMPLE Value = $d \text{ mm} \pm 0.2 \text{ mm}$; total uncertainty $\leq 0.05 \text{ mm}$.

During the performance of the measurement, ensure that any mechanical force applied to the edge of the card during measurement does not exceed 6 N per 10 mm length.

NOTE An optical method may be used.

4.3 Thickness

4.3.1 Reference

ISO/IEC 15457-1, Annex A or B.

4.3.2 Apparatus

Dead weight micrometer.

4.3.3 Procedure

Determine the thickness of paper or composite TFCs in accordance with ISO 534, using a pressure of 100 kPa, outside the data recording area. Thickness shall be the average measurement of three different measurements taken on the same card in three different locations.

4.4 Separation force

4.4.1 Reference

ISO/IEC 15457-1, Separation force.

ISO/IEC 15457-1, Perforations.

4.4.2 Principle

To measure, in the direction of the width of the samples, the force needed to break the bridges of the perforated line between two parts of a card or between two cards.

4.4.3 Apparatus

A tensile tester, including a dynamometer able to apply a force of at least 500 N with a speed of 100 mm/min. Figure 1 shows the arrangement of the test piece in the apparatus.

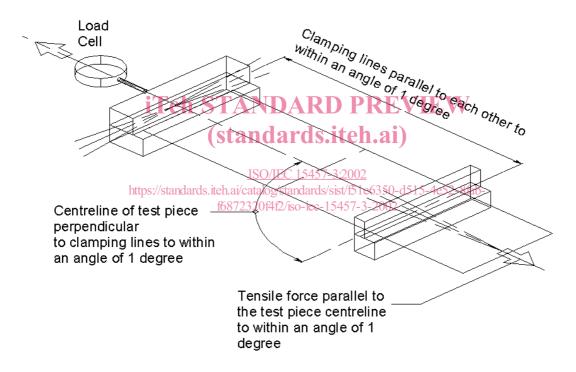


Figure 1 — Test arrangement for separation force

4.4.4 Procedure

Take sufficient samples to prepare ten test pieces which include the perforation line to be tested and prepare the test pieces such that the test is carried out on the full height of the card.

Carefully open out any test pieces which are folded. Keep five test pieces unfolded and fold all the other test pieces 5 times through an angle of 180° (i.e. from the fully open state to the fully closed state).

Measure the separation force for each test piece at a speed of 100 mm/min.

4.4.5 Expression of result

For each test, before or after folding, express the result as the average value of the individual values.